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## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

re application of

Akihisa HONGO et al.

Serial No. 09/762,582

Attn: Application Branch

Filed April 12, 2001

Attorney Docket No. 2001\_0133A

SUBSTRATE PLATING METHOD AND APPARATUS

## REQUEST FOR CORRECTION OF PATENT OFFICE RECORDS

Assistant Commissioner for Patents, Washington, DC 20231

Sir:

The title of the invention indicated on the official filing receipt reflects the title used in the international application. Accordingly, please correct the official Patent Office records to reflect the title indicated in the declaration and specification, i.e.

## --SUBSTRATE PLATING METHOD AND APPARATUS--

A corrected filing receipt is requested in the above-referenced case. A copy of the original filing receipt is enclosed, with the changes noted thereon.

Respectfully submitted,

Akihisa HONGO et al.

Ву

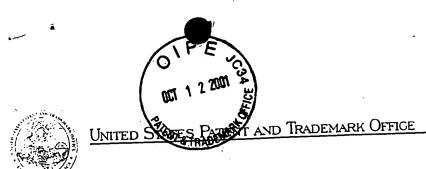
Michael S. Huppert

Registration No. 40,268

Attorney for Applicants

MSH/kjf Washington, D.C. 20006-1021 Telephone (202) 721-8200 Facsimile (202) 721-8250 October 12, 2001

THE COMMISSIONER IS AUTHORIZED TO CHARGE ANY DEFICIENCY IN THE FEE FOR THIS PAPER TO DEPOSIT ACCOUNT NO. 23-0975.



COMM SSIONER FOR PATENTS
UNITED STATES PATENT AND TRADEMARK OFFICE
WASHINGTON, D.C. 20231
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IND CLAIMS TOT CLAIMS DRAWINGS ATTY.DOCKET.NO FIL FEE REC'D GRP ART UNIT FILING DATE APPLICATION NUMBER 3 11 18 2001-0133A 1044 1741 04/12/2001 09/762,582

000513 WENDEROTH, LIND & PONACK, L.L.P. 2033 K STREET N. W. SUITE 800 WASHINGTON, DC 20006-1021 CONFIRMATION NO. 5731

CORRECTED FILING RECEIPT

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Date Mailed: 09/11/2001

Receipt is acknowledged of this nonprovisional Patent Application. It will be considered in its order and you will be notified as to the results of the examination. Be sure to provide the U.S. APPLICATION NUMBER, FILING DATE, NAME OF APPLICANT, and TITLE OF INVENTION when inquiring about this application. Fees transmitted by check or draft are subject to collection. Please verify the accuracy of the data presented on this receipt. If an error is noted on this Filing Receipt, please write to the Office of Initial Patent Examination's Customer Service Center. Please provide a copy of this Filing Receipt with the changes noted thereon. If you received a "Notice to File Missing Parts" for this application, please submit any corrections to this Filing Receipt with your reply to the Notice. When the USPTO processes the reply to the Notice, the USPTO will generate another Filing Receipt incorporating the requested corrections (if appropriate).

Applicant(s)

Akihisa Hongo, Tokyo, JAPAN;
Naoaki Ogure, Tokyo, JAPAN;
Hiroaki Inoue, Tokyo, JAPAN;
Satoshi Sendai, Tokyo, JAPAN;
Tetsuma Ikegami, Tokyo, JAPAN;
Koji Mishima, Tokyo, JAPAN;
Shuichi Okuyama, Tokyo, JAPAN;
Mizuki Nagai, Tokyo, JAPAN;
Ryoichi Kimizuka, Tokyo, JAPAN;
Megumi Maruyama, Kanagawa, JAPAN;

Domestic Priority data as claimed by applicant

THIS APPLICATION IS A 371 OF PCT/JP99/04349 08/11/1999

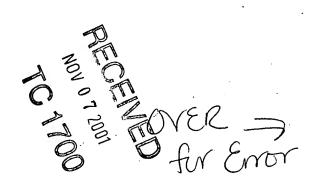
Foreign Applications

JAPAN 10-239490 08/11/1998 JAPAN 11-30230 02/08/1999 JAPAN 11-220363 08/03/1999

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Projected Publication Date: N/A

Non-Publication Request: No



Early Publication Request: No

Title

Substrate Plating Method and Apparatus Wafer-plating method and apparatus

**Preliminary Class** 

205

Data entry by : HINES, BRENDA

Team: 1700

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